Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/500,696	KIM ET AL.
Examiner	Art Unit
Benjamin P. Blumel	1648

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
STIC searched SEQ ID NO:s 1-4				

SEARCH N (INCLUDING SEAR	NOTES CH STRATEGY	")
	DATE	EXMR
East	3/27/2007	BPB
Pubmed	3/27/2007	BPB
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